

<b>Notice of References Cited</b>	Application/Control No. 10/815,881	Applicant(s)/Patent Under Reexamination ALGER ET AL.	
	Examiner Tae H. Yoon	Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,946,084	09-2005	Nakagawa et al.	252/500
*	B	US-6,822,026	11-2004	Jung et al.	524/141
*	C	US-6,258,879	07-2001	Adedeji et al.	524/127
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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